


<b>Search Notes</b>  	<b>Application/Control No.</b>  10700014	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  Eric Liou	<b>Art Unit</b>  3628

SEARCHED			
Class	Subclass	Date	Examiner
705		4/2/2008	Eric Liou
705	1	1/5/10	A.R.
705	5	1/5/10	A.R.
705	6	1/5/10	A.R.
705	26	1/5/10	A.R.

SEARCH NOTES		
Search Notes	Date	Examiner
East	4/2/2008	Eric Liou
705 (text search only - see attached search history)	4/2/2008	Eric Liou

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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